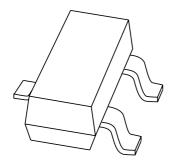
## **DISCRETE SEMICONDUCTORS**

# DATA SHEET



## BAV199 Low-leakage double diode

Product specification Supersedes data of 1999 May 11 2001 Oct 12





## Low-leakage double diode

**BAV199** 

#### **FEATURES**

- Plastic SMD package
- · Low leakage current: typ. 3 pA
- Switching time: typ. 0.8 μs
- Continuous reverse voltage: max. 75 V
- Repetitive peak reverse voltage: max. 85 V
- Repetitive peak forward current: max. 500 mA.

#### **APPLICATION**

 Low-leakage current applications in surface mounted circuits.

#### **DESCRIPTION**

Epitaxial, medium-speed switching, double diode in a small SOT23 plastic SMD package. The diodes are connected in series.

#### **MARKING**

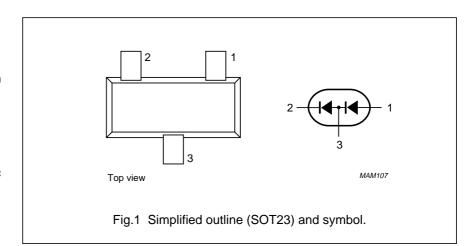
TYPE NUMBER	MARKING CODE <sup>(1)</sup>
BAV199	JY*

#### Note

1. \* = p: Made in Hong Kong.\* = t: Made in Malaysia.\* = W: Made in China.

#### **PINNING**

PIN	DESCRIPTION
1	anode
2	cathode
3	anode; cathode



#### **LIMITING VALUES**

In accordance with the Absolute Maximum Rating System (IEC 60134).

SYMBOL	PARAMETER	PARAMETER CONDITIONS		MAX.	UNIT
Per diode			•	•	•
$V_{RRM}$	repetitive peak reverse voltage		_	85	V
$V_R$	continuous reverse voltage		_	75	V
I <sub>F</sub>	continuous forward current	single diode loaded; note 1; see Fig.2	_	160	mA
		double diode loaded; note 1; see Fig.2	_	140	mA
I <sub>FRM</sub>	repetitive peak forward current		_	500	mA
I <sub>FSM</sub>	non-repetitive peak forward current	square wave; T <sub>j</sub> = 25 °C prior to surge; see Fig.4			
		$t_p = 1 \mu s$	_	4	Α
		$t_p = 1 \text{ ms}$	_	1	Α
		t <sub>p</sub> = 1 s	_	0.5	Α
P <sub>tot</sub>	total power dissipation	T <sub>amb</sub> = 25 °C; note 1	_	250	mW
T <sub>stg</sub>	storage temperature		-65	+150	°C
Tj	junction temperature		_	150	°C

#### Note

1. Device mounted on a FR4 printed-circuit board.

## Low-leakage double diode

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#### **ELECTRICAL CHARACTERISTICS**

 $T_i = 25$  °C unless otherwise specified.

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
Per diode				•	
V <sub>F</sub>	forward voltage	see Fig.3			
		I <sub>F</sub> = 1 mA	_	900	mV
		I <sub>F</sub> = 10 mA	_	1000	mV
		I <sub>F</sub> = 50 mA	_	1100	mV
		I <sub>F</sub> = 150 mA	_	1250	mV
I <sub>R</sub>	reverse current	see Fig.5			
		V <sub>R</sub> = 75 V	0.003	5	nA
		V <sub>R</sub> = 75 V; T <sub>j</sub> = 150 °C	3	80	nA
C <sub>d</sub>	diode capacitance	f = 1 MHz; V <sub>R</sub> = 0; see Fig.6	2	_	pF
t <sub>rr</sub>	reverse recovery time	when switched from $I_F = 10$ mA to	0.8	3	μs
		$I_R$ = 10 mA; $R_L$ = 100 $\Omega$ ; measured at $I_R$ = 1 mA; see Fig.7			

#### THERMAL CHARACTERISTICS

SYMBOL	PARAMETER	CONDITIONS	VALUE	UNIT
R <sub>th j-tp</sub>	thermal resistance from junction to tie-point		360	K/W
R <sub>th j-a</sub>	thermal resistance from junction to ambient	note 1	500	K/W

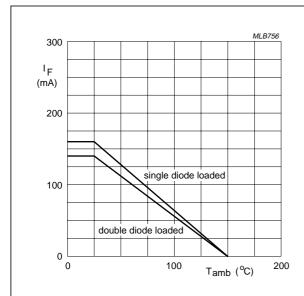
#### Note

1. Device mounted on a FR4 printed-circuit board.

## Low-leakage double diode

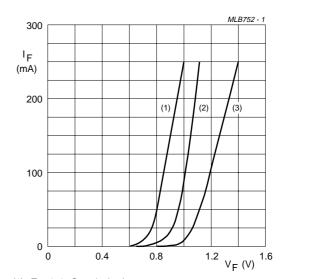
**BAV199** 

#### **GRAPHICAL DATA**



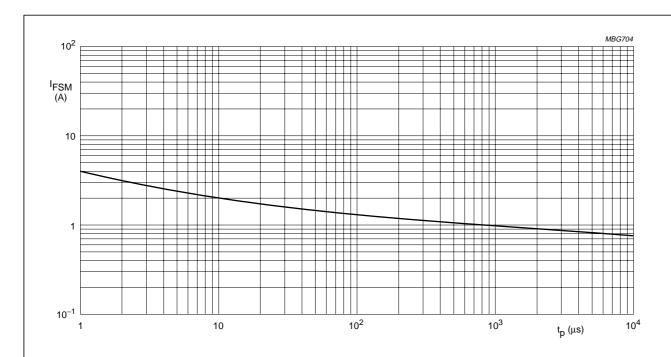
Device mounted on a FR4 printed-circuit board.

Fig.2 Maximum permissible continuous forward current as a function of ambient temperature.



- (1)  $T_j = 150$  °C; typical values.
- (2)  $T_j = 25$  °C; typical values.
- (3)  $T_j = 25$  °C; maximum values.

Fig.3 Forward current as a function of forward voltage; per diode.

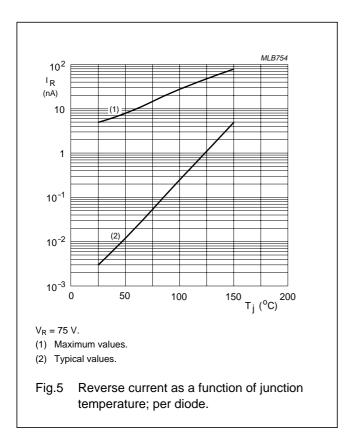


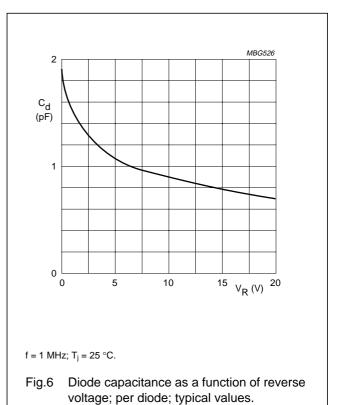
Based on square wave currents;  $T_j = 25$  °C prior to surge.

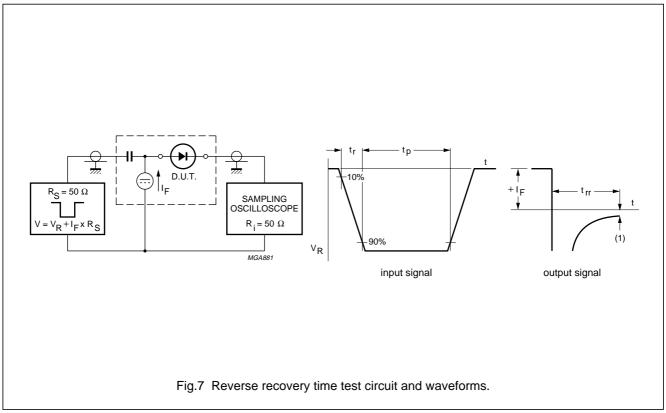
Fig.4 Maximum permissible non-repetitive peak forward current as a function of pulse duration per diode.

## Low-leakage double diode

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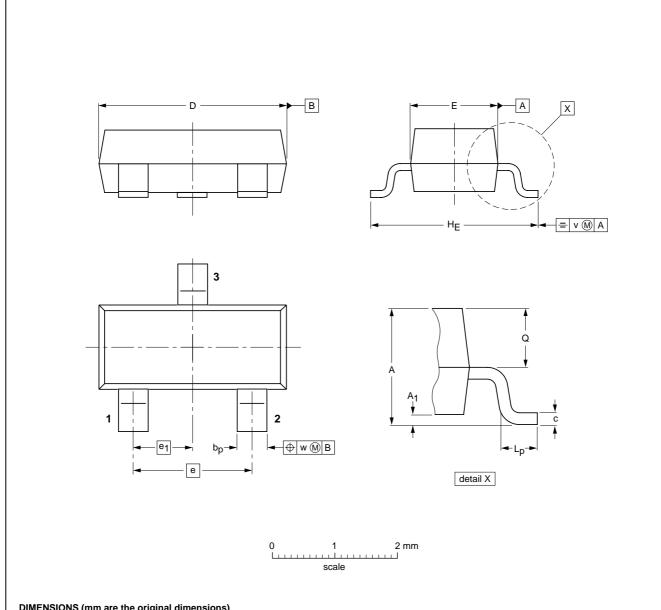
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#### **PACKAGE OUTLINE**

Plastic surface mounted package; 3 leads

SOT23



#### **DIMENSIONS** (mm are the original dimensions)

UNIT	Α	A <sub>1</sub> max.	bp	С	D	E	е	e <sub>1</sub>	HE	L <sub>p</sub>	Q	v	w
mm	1.1 0.9	0.1	0.48 0.38	0.15 0.09	3.0 2.8	1.4 1.2	1.9	0.95	2.5 2.1	0.45 0.15	0.55 0.45	0.2	0.1

OUTLINE		REFER	EUROPEAN	ISSUE DATE		
VERSION	IEC	JEDEC	JEDEC EIAJ PROJECTION		ISSUE DATE	
SOT23		TO-236AB				<del>-97-02-28-</del> 99-09-13

2001 Oct 12 6

### Low-leakage double diode

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DATA SHEET STATUS(1)	PRODUCT STATUS <sup>(2)</sup>	DEFINITIONS
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